

# DB Tester Board Specification (v7)

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The daughterboard tester is designed to simulate some features of the QB module.

## SDS Control Functions

Various parameters of SDS may be controlled on the DB tester by writing to registers on the tester. Use EthDBlib functions EthUDPWrite() and EthUDPRead() to access these registers. See Table 1 for details.

## QB “Dummy Data” Emulation

If bits 1-0 in register 0xe000 are set to '11', the tester board will emulate the QB by producing “dummy data.” In this case, SDS will be started by SDSREQ from QB. SDSREQ must be enabled on DB by writing '1' to bit 7 of DB register 0x106. See QB-DB Firmware Specification for details of DB registers.

Basic startup procedure for this mode:

1. Write '0' to register 0xe000
2. Write to register 0xe002 to set desired number of hits per event.
3. Set desired parameters of SDS in registers 0xe010-0xe018.
4. Write 0x3 to register 0xe000 to enable QB “dummy data” mode.
5. Start the test by writing 0x80 to register 0x106

Address	r/w	bit(s)	Description
0xe000	r/w	0-1	When '01', tester will generate sequential data When '10', tester will generate pseudo-random data (byLFSR) When '11', special test format data. Bits 2 and 6 (below) have no function in this mode, <i>i.e.</i> , Q is controlled by length and SDS burst length is always a multiple of 3. See Table 2 for more information about this special test data mode. Otherwise, data written to 0x8000
	r/w	2	When '1', SDS always gets Q response (SDS never ends by Q)
	r/w	3	When '0', SDS burst length controlled by register 0xe002 When '1', SDS burst length is random (for random, maximum burst length can be set by register 0xe008)
	r/w	4	When '0', G_trig interval controlled by register 0xe004 When '1', G_trig occurs at random interval (for random, maximum interval can be set by register 0xe00a)
	r/w	5	When '0', SDSREQ interval controlled by register 0xe006 When '1', SDSREQ occurs at random interval (for random, maximum interval can be set by register 0xe00c)
	r/w	6	When '0', force SDS burst length to multiple of 3 words (rounds up)
	r/w	7	When '1', enable JTAG programming of old (revision 1) DB
	r	8-15	DB Tester firmware version (read only)
0xe002	r/w	0-15	Set SDS burst length (minimum 2. If less than 2, still reads as 2)
0xe004	r/w	0-15	Set G_trig interval (in units of 150 ns)
0xe006	r/w	0-15	Set SDSREQ interval (in units of 150 ns)
0xe008	r/w	0-15	Random SDS burst length mask. Set bits 15 through N to '1' to limit maximum burst length to N-bits long
0xe00a	r/w	0-15	Random G_trig interval mask. Set bits 15 through N to '1' to limit maximum interval to N-bits long
0xe00c	r/w	0-15	Random SDSREQ interval mask. Set bits 15 through N to '1' to limit maximum interval to N-bits long

Table 1: SDS control registers

Address	r/w	bit(s)	Description
0xe010	r/w	0-15	Number of hits per event. Must be greater than or equal to parameter 'A' in register 0xe012.
0xe012	r/w	0-15	Parameter 'A'
0xe014	r/w	0-15	Parameter 'B' (should not be 0)
0xe016	r/w	0-15	Set LFSR starting state. Do not set to all '1'.
0xe018	r/w	0-6	Sets output data rate (units of 1 Mbit/s)

*Table 2: Registers for QB “dummy data” emulation. These registers are only used when register 0xe000 bits 0-1 are set to '11'*

## General Comments

All registers on tester will be reset by DB 'QB reset' command (UDP write 0x0080 to DB address 0x0000).

This version of tester firmware (v7) is designed for the revision 2 DBs. To program revision 1 DB with JTAG, bit 7 of register 0xe000 must be set to '1'.